## N-Channel FREDFET

POWER MOS $8^{\circledR}$ is a high speed, high voltage N -channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced $t_{r r}$, soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of $\mathrm{C}_{\text {rss }} / \mathrm{C}_{\text {iss }}$ result in excellent niose immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.


APT17F120J
Single die FREDFET


## FEATURES

- Fast switching with low EMI
- Low $\mathrm{t}_{\mathrm{rr}}$ for high reliability
- Ultra low $\mathrm{C}_{\text {rss }}$ for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant


## TYPICAL APPLICATIONS

- ZVS phase shifted and other full full bridge
- Half bridge
- PFC and other boost converter
- Buck converter
- Single and two switch forward
- Flyback


## Absolute Maximum Ratings

| Symbol | Parameter | Ratings | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{I}_{\mathrm{D}}$ | Continuous Drain Current $@ \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 18 |  |
|  | Continuous Drain Current $@ \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ | 12 | A |
| $\mathrm{I}_{\mathrm{DM}}$ | Pulsed Drain Current ${ }^{(1)}$ | 104 |  |
| $\mathrm{~V}_{\mathrm{GS}}$ | Gate-Source Voltage | $\pm 30$ | V |
| $\mathrm{E}_{\mathrm{AS}}$ | Single Pulse Avalanche Energy ${ }^{(2)}$ | 2165 | mJ |
| $\mathrm{I}_{\text {AR }}$ | Avalanche Current, Repetitive or Non-Repetitive | 14 | A |

Thermal and Mechanical Characteristics

| Symbol | Characteristic | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{P}_{\mathrm{D}}$ | Total Power Dissipation @ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  |  | 545 | W |
| $\mathrm{R}_{\text {өJC }}$ | Junction to Case Thermal Resistance |  |  | 0.23 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{\theta Cs}}$ | Case to Sink Thermal Resistance, Flat, Greased Surface |  | 0.15 |  |  |
| $\mathrm{T}_{\mathrm{J},}, \mathrm{T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range | -55 |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\text {Isolation }}$ | RMS Voltage ( $50-60 \mathrm{hHz}$ Sinusoidal Wavefomr from Terminals to Mounting Base for 1 Min.) | 2500 |  |  | V |
| $\mathrm{W}_{\mathrm{T}}$ | Package Weight |  | 1.03 |  | OZ |
|  |  |  | 29.2 |  | g |
| Torque | Terminals and Mounting Screws. |  |  | 10 | in.lbf |
|  |  |  |  | 1.1 | $\mathrm{N} \cdot \mathrm{m}$ |

Static Characteristics
$\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise specified
APT17F120J

| Symbol | Parameter | Test Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {BR(DSS }}$ | Drain-Source Breakdown Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 1200 |  |  | V |
| $\Delta \mathrm{V}_{\mathrm{BR}(\mathrm{DSS})} / \Delta \mathrm{T}_{\mathrm{j}}$ | Breakdown Voltage Temperature Coefficient | Reference to $25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  |  | 1.41 |  | $\mathrm{V} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | Drain-Source On Resistance ${ }^{(3)}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=14 \mathrm{~A}$ |  |  | 0.55 | 0.58 | $\Omega$ |
| $\mathrm{V}_{\mathrm{GS}(\mathrm{th})}$ | Gate-Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=2.5 \mathrm{~mA}$ |  | 2.5 | 4 | 5 | V |
| $\Delta \mathrm{V}_{\mathrm{GS}(\text { th }} / \Delta \mathrm{T}_{\mathrm{J}}$ | Threshold Voltage Temperature Coefficient |  |  |  | -10 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{I}_{\text {DSS }}$ | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=1200 \mathrm{~V}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  |  | 250 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{v}_{\mathrm{GS}}=\mathrm{ov}$ | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  |  | 1000 |  |
| $\mathrm{I}_{\text {GSS }}$ | Gate-Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 30 \mathrm{~V}$ |  |  |  | $\pm 100$ | nA |

Dynamic Characteristics
$\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise specified

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{g}_{\text {fs }}$ | Forward Transconductance | $\mathrm{V}_{\mathrm{DS}}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=14 \mathrm{~A}$ |  | 31 |  | S |
| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\begin{gathered} V_{G S}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=25 \mathrm{~V} \\ f=1 \mathrm{MHz} \end{gathered}$ |  | 9670 |  | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  |  | 115 |  |  |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  |  | 715 |  |  |
| $\mathrm{C}_{\mathrm{o}(\mathrm{cr})}{ }^{(4)}$ | Effective Output Capacitance, Charge Related | $V_{G S}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ to 800 V |  | 275 |  |  |
| $\mathrm{C}_{\text {o(er) }}{ }^{\text {(5) }}$ | Effective Output Capacitance, Energy Related |  |  | 140 |  |  |
| $Q_{g}$ | Total Gate Charge | $\begin{gathered} V_{G S}=0 \text { to } 10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=14 \mathrm{~A}, \\ V_{D S}=600 \mathrm{~V} \end{gathered}$ |  | 300 |  | nC |
| $Q_{\text {gs }}$ | Gate-Source Charge |  |  | 50 |  |  |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate-Drain Charge |  |  | 140 |  |  |
| $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | Turn-On Delay Time | Resistive Switching$\begin{gathered} V_{D D}=800 \mathrm{~V}, I_{D}=14 \mathrm{~A} \\ R_{G}=2.2 \Omega^{(6)}, V_{G G}=15 \mathrm{~V} \end{gathered}$ |  | 50 |  | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Current Rise Time |  |  | 31 |  |  |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  |  | 170 |  |  |
| $\mathrm{t}_{\text {f }}$ | Current Fall Time |  |  | 48 |  |  |

## Source-Drain Diode Characteristics

| Symbol | Parameter | Test Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $I_{s}$ | Continuous Source Current (Body Diode) | MOSFET symbol showing the integral reverse p-n junction diode (body diode) |  |  |  | 18 | A |
| $I_{\text {SM }}$ | Pulsed Source Current (Body Diode) ${ }^{\text {(1) }}$ |  |  |  |  | 104 |  |
| $\mathrm{V}_{\text {SD }}$ | Diode Forward Voltage | $\mathrm{I}_{\text {SD }}=14 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  |  | 1.1 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\begin{gathered} \mathrm{I}_{\mathrm{SD}}=14 \mathrm{~A}^{(3)} \\ \mathrm{di}_{\mathrm{SD}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} \end{gathered}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  |  | 330 |  |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  |  | 660 | ns |
| $\mathrm{Q}_{\mathrm{rr}}$ | Reverse Recovery Charge |  | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  | 1.72 |  | $\mu \mathrm{C}$ |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 4.67 |  |  |
| $I_{\text {rrm }}$ | Reverse Recovery Current |  | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  | 11 |  | A |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 16 |  |  |
| dv/dt | Peak Recovery dv/dt | $\begin{gathered} \mathrm{I}_{\mathrm{SD}} \leq 14 \mathrm{~A}, \mathrm{di} / \mathrm{dt} \leq 1000 \mathrm{~A} / \mu \mathrm{s}, \mathrm{~V}_{\mathrm{DD}}=100 \mathrm{~V}, \\ \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{gathered}$ |  |  |  | 25 | V/ns |

(1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
(2) Starting at $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{L}=22.1 \mathrm{mH}, \mathrm{R}_{\mathrm{G}}=25 \Omega, \mathrm{I}_{\mathrm{AS}}=14 \mathrm{~A}$.
(3) Pulse test: Pulse Width $<380 \mu \mathrm{~s}$, duty cycle $<2 \%$.
(4) $\mathrm{C}_{\mathrm{O}(\mathrm{cr})}$ is defined as a fixed capacitance with the same stored charge as $\mathrm{C}_{\mathrm{OSS}}$ with $\mathrm{V}_{\mathrm{DS}}=67 \%$ of $\mathrm{V}_{\text {(BR)DSS }}$
(5) $\mathrm{C}_{\mathrm{o}(\text { er) }}$ is defined as a fixed capacitance with the same stored energy as $\mathrm{C}_{\mathrm{Oss}}$ with $\mathrm{V}_{\mathrm{DS}}=67 \%$ of $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSs}}$. To calculate $\mathrm{C}_{\mathrm{o}(\text { er) }}$ for any value of $\mathrm{V}_{\mathrm{DS}}$ less than $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSs},}$, use this equation: $\mathrm{C}_{\mathrm{o}(\text { er })}=-8.27 \mathrm{E}-7 / \mathrm{V}_{\mathrm{DS}}{ }^{\wedge} 2+1.01 \mathrm{E}-7 / \mathrm{V}_{\mathrm{DS}}+1.43 \mathrm{E}-10$.
(6) $R_{G}$ is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

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Figure 1, Output Characteristics


Figure 3, $\mathbf{R}_{\mathrm{DS}(\mathrm{ON})}$ vs Junction Temperature


Figure 5, Gain vs Drain Current


Figure 7, Gate Charge vs Gate-to-Source Voltage


Figure 2, Output Characteristics


Figure 4, Transfer Characteristics


Figure 6, Capacitance vs Drain-to-Source Voltage


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration


Dimensions in Millimeters and (Inches)


[^0]:    Microsemi reserves the right to change, without notice, the specifications and information contained herein.

